





**PATENTS** 

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s):

Tomoyuki Taguchi

Examiner:

Emily Y. Chan

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**Art Unit:** 

2829

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For: INSPECTION METHOD FOR ARRAY SUBSTRATE AND INSPECTION DEVICE **Dated:** May 20, 2003

FOR THE SAME

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

## **AMENDMENT UNDER 37 CFR 1.111**

Sir:

Responsive to the Office Action of February 20, 2003, please amend this patent application as follows:

CERTIFICATE OF MAILING UNDER 37 C.F.R. §1.8(2)

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on May 20, 2003.

Dated: May 20, 2003

Michelle Mustafa